

Notice of References Cited	Application/Control No. 10/825,853		Applicant(s)/Patent Under Reexamination ACHARYA, CHIRANJIT	
	Examiner Russell Frejd		Art Unit 2128	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,449,612	09-2002	Bradley et al.	707/6
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	WANG et al., Y. Data Mapping by Probabilistic Modular Networks and Information-Theoretic Criteria, IEEE Transactions on Signal Processing, Vol. 46, No. 12, December 1998, pp. 3378-97.
	V	LANGAN et al., D.A. Cluster Validation for Unsupervised Stochastic Model-Based Image Segmentation, IEEE Transactions on Image Processing, Vol. 7, No. 2, February 1998, pp. 180-95.
	W	WANG et al., Y. Probabilistic Principal Component Subspaces: A Hierarchical Finite Mixture Model for Data Visualization, IEEE Transactions on Neural Networks, Vol. 11, No. 3, May 2000, pp. 625-36.
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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